

NTMFS4926N

Power MOSFET

30 V, 44 A, Single N-Channel, SO-8 FL

Features

- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Optimized for 5 V, 12 V Gate Drives
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current R _{θJA} (Note 1)	Steady State	T _A = 25°C	I _D	15.5	A
		T _A = 100°C		9.8	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	2.70	W
Continuous Drain Current R _{θJA} ≤ 10 s (Note 1)		T _A = 25°C	I _D	23.4	A
		T _A = 100°C		14.8	
Power Dissipation R _{θJA} ≤ 10 s (Note 1)		T _A = 25°C	P _D	6.13	W
Continuous Drain Current R _{θJA} (Note 2)		T _A = 25°C	I _D	9.0	A
		T _A = 100°C		5.7	
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	0.92	W
Continuous Drain Current R _{θJC} (Note 1)		T _C = 25°C	I _D	44	A
		T _C = 100°C		28	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	21.6	W
Pulsed Drain Current	T _A = 25°C, t _p = 10 μs		I _{DM}	182	A
Current Limited by Package		T _A = 25°C	I _{Dmax}	100	A
Operating Junction and Storage Temperature			T _J , T _{STG}	−55 to +150	°C
Source Current (Body Diode)			I _S	21	A
Drain to Source DV/DT			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 24 V, V _{GS} = 20 V, I _L = 21 A _{pk} , L = 0.1 mH, R _G = 25 Ω)			E _{AS}	22	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

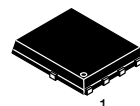
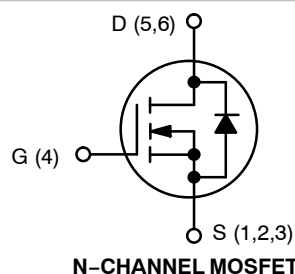
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
2. Surface-mounted on FR4 board using the minimum recommended pad size.



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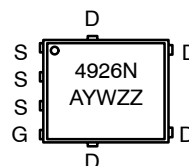
<http://onsemi.com>

$V_{(BR)DSS}$	$R_{DS(ON)}$ MAX	I_D MAX
30 V	7.0 m Ω @ 10 V	44 A
	11.2 m Ω @ 4.5 V	



SO-8 FLAT LEAD
CASE 488AA
STYLE 1

MARKING DIAGRAM



A = Assembly Location
Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping†
NTMFS4926NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4926NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	5.8	°C/W
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	46.3	
Junction-to-Ambient – Steady State (Note 4)	$R_{\theta JA}$	136.2	
Junction-to-Ambient – ($t \leq 10$ s) (Note 3)	$R_{\theta JA}$	20.4	

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	30			V
Drain-to-Source Breakdown Voltage (transient)	$V_{(BR)DSS(t)}$	$V_{GS} = 0\text{ V}, I_{D(aval)} = 8.8\text{ A}, T_{case} = 25^\circ\text{C}, t_{transient} = 100\text{ ns}$	34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$			25		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = 24\text{ V}$	$T_J = 25^\circ\text{C}$		1.0	μA
			$T_J = 125^\circ\text{C}$		10	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			± 100	nA

ON CHARACTERISTICS (Note 5)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\text{ }\mu\text{A}$	1.32	1.6	2.2	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			3.8		mV/°C
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$	$I_D = 30\text{ A}$	5.6	7.0	m Ω
			$I_D = 15\text{ A}$	5.6		
		$V_{GS} = 4.5\text{ V}$	$I_D = 30\text{ A}$	9.0	11.2	
			$I_D = 15\text{ A}$	8.7		
Forward Transconductance	g_{FS}	$V_{DS} = 1.5\text{ V}, I_D = 15\text{ A}$		40		S

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C_{ISS}	$V_{GS} = 0\text{ V}, f = 1\text{ MHz}, V_{DS} = 15\text{ V}$		1004		pF
Output Capacitance	C_{OSS}			390		
Reverse Transfer Capacitance	C_{RSS}			119		
Capacitance	C_{RSS} / C_{ISS}	$V_{GS} = 0\text{ V}, V_{DS} = 15\text{ V}, f = 1\text{ MHz}$		0.119	0.237	
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V}; I_D = 30\text{ A}$		8.7		nC
Threshold Gate Charge	$Q_{G(TH)}$			1.4		
Gate-to-Source Charge	Q_{GS}			3.0		
Gate-to-Drain Charge	Q_{GD}			3.5		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10\text{ V}, V_{DS} = 15\text{ V}; I_D = 30\text{ A}$		17.3		nC

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V}, I_D = 15\text{ A}, R_G = 3.0\text{ }\Omega$		8.6		ns
Rise Time	t_r			36.9		
Turn-Off Delay Time	$t_{d(OFF)}$			14.7		
Fall Time	t_f			5.5		

5. Pulse Test: pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = 10\text{ V}, V_{DS} = 15\text{ V},$ $I_D = 15\text{ A}, R_G = 3.0\ \Omega$		6.6		ns
Rise Time	t_r			31.8		
Turn-Off Delay Time	$t_{d(OFF)}$			18.3		
Fall Time	t_f			4.0		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$V_{GS} = 0\text{ V},$ $I_S = 30\text{ A}$	$T_J = 25^\circ\text{C}$		0.87	1.1	V
			$T_J = 125^\circ\text{C}$		0.76		
Reverse Recovery Time	t_{RR}	$V_{GS} = 0\text{ V}, dI_S/dt = 100\text{ A}/\mu\text{s},$ $I_S = 30\text{ A}$			21.9		ns
Charge Time	t_a				11.0		
Discharge Time	t_b				10.9		
Reverse Recovery Charge	Q_{RR}				8.0		nC

PACKAGE PARASITIC VALUES

Source Inductance	L_S	$T_A = 25^\circ\text{C}$		1.00		nH
Drain Inductance	L_D			0.005		nH
Gate Inductance	L_G			1.84		nH
Gate Resistance	R_G			1.0	2.2	Ω

5. Pulse Test: pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

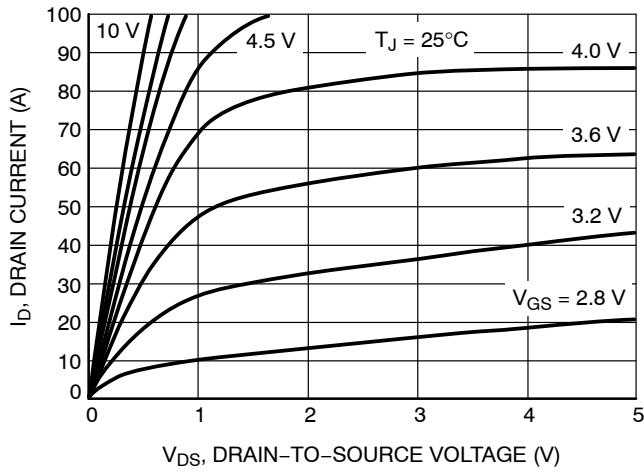


Figure 1. On-Region Characteristics

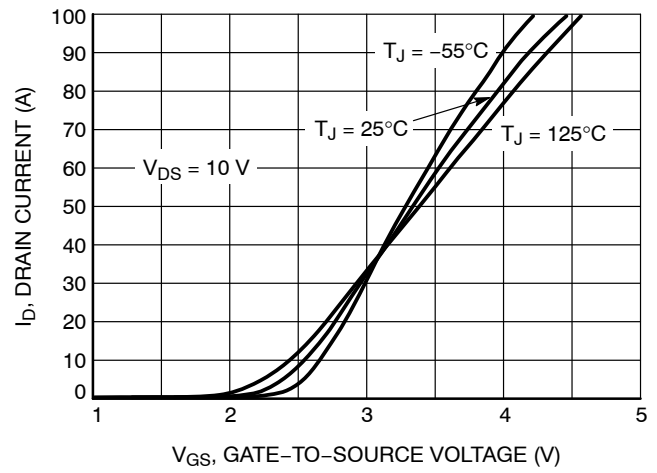


Figure 2. Transfer Characteristics

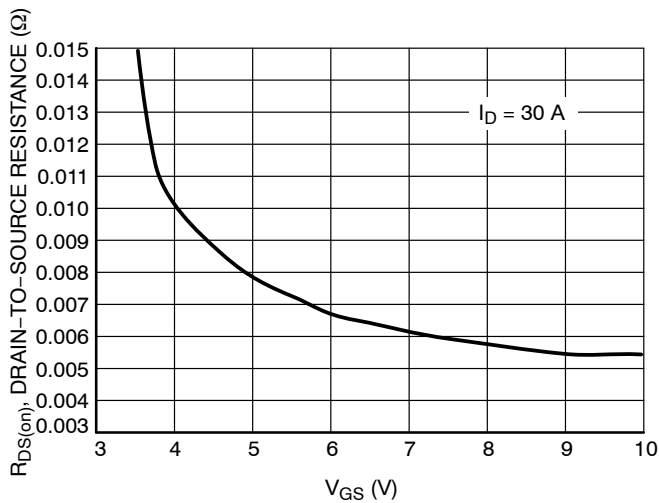


Figure 3. On-Resistance vs. V_{GS}

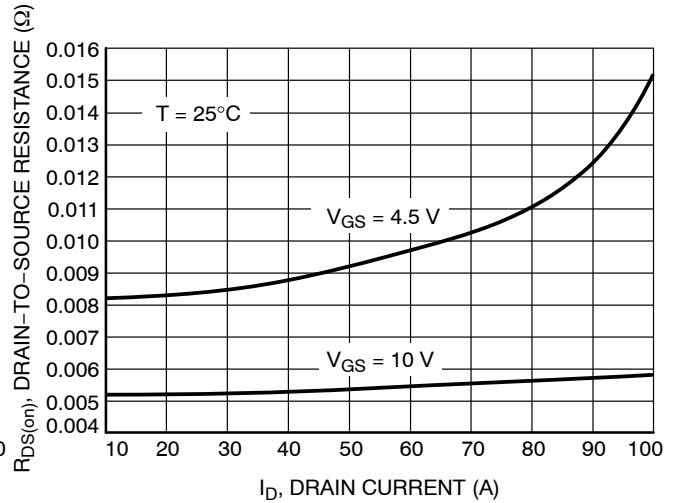


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

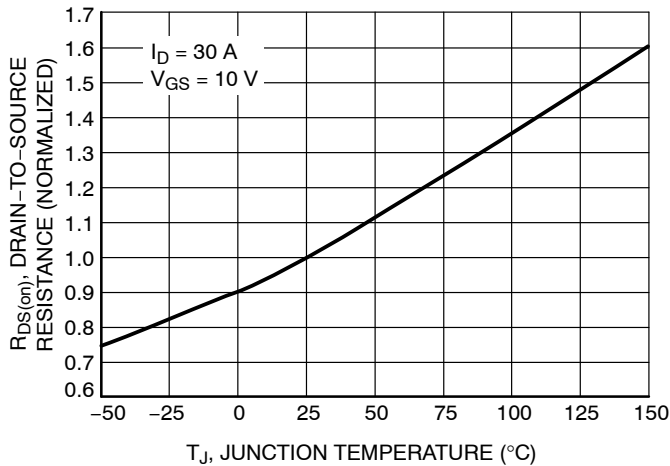


Figure 5. On-Resistance Variation with Temperature

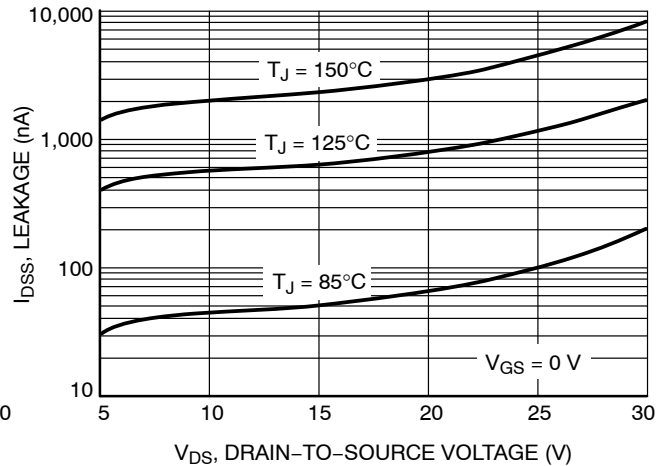


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

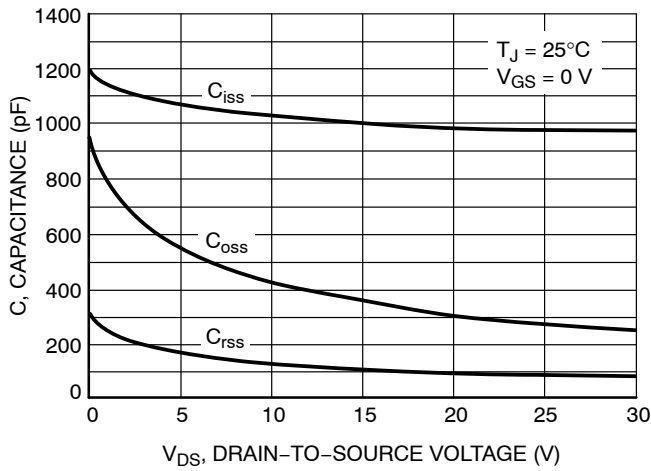


Figure 7. Capacitance Variation

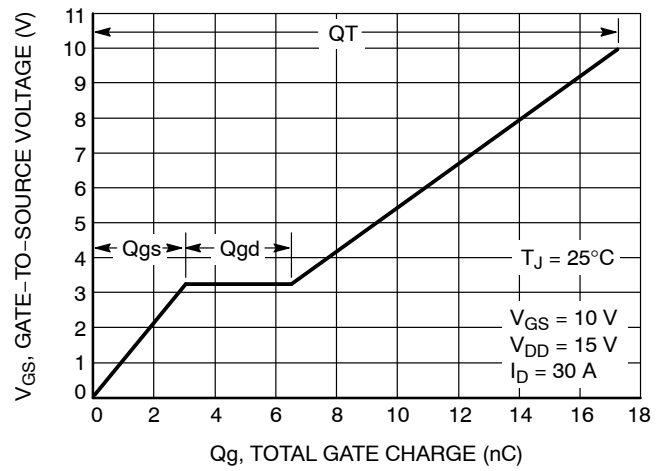


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

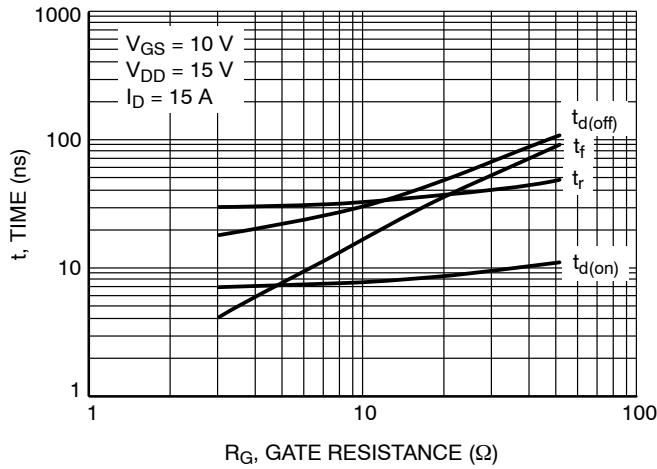


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

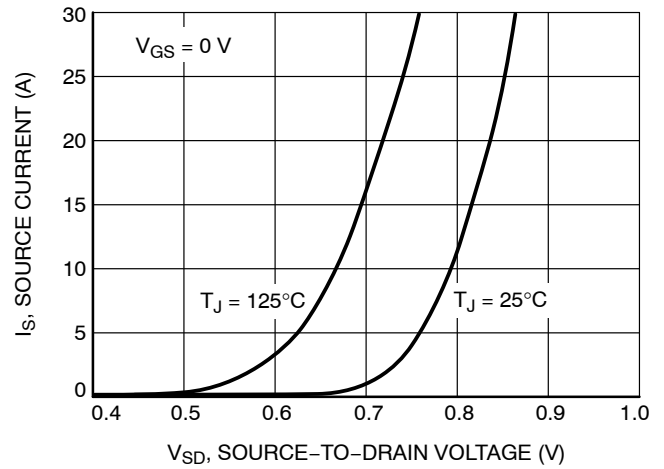


Figure 10. Diode Forward Voltage vs. Current

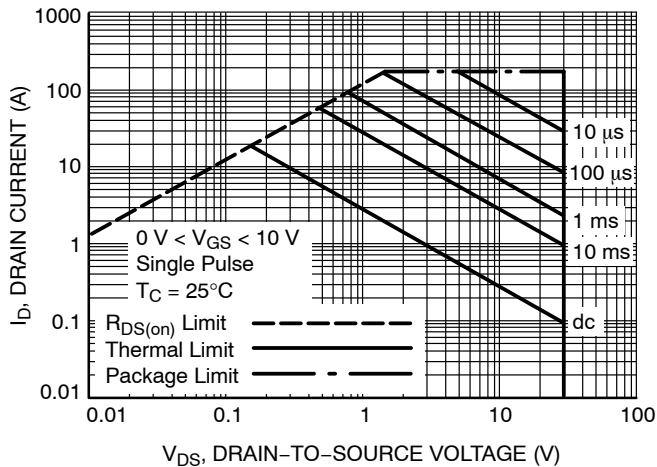


Figure 11. Maximum Rated Forward Biased Safe Operating Area

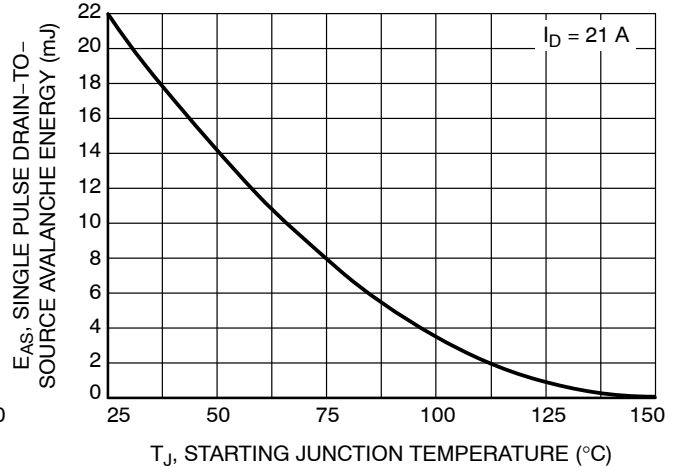


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

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TYPICAL CHARACTERISTICS

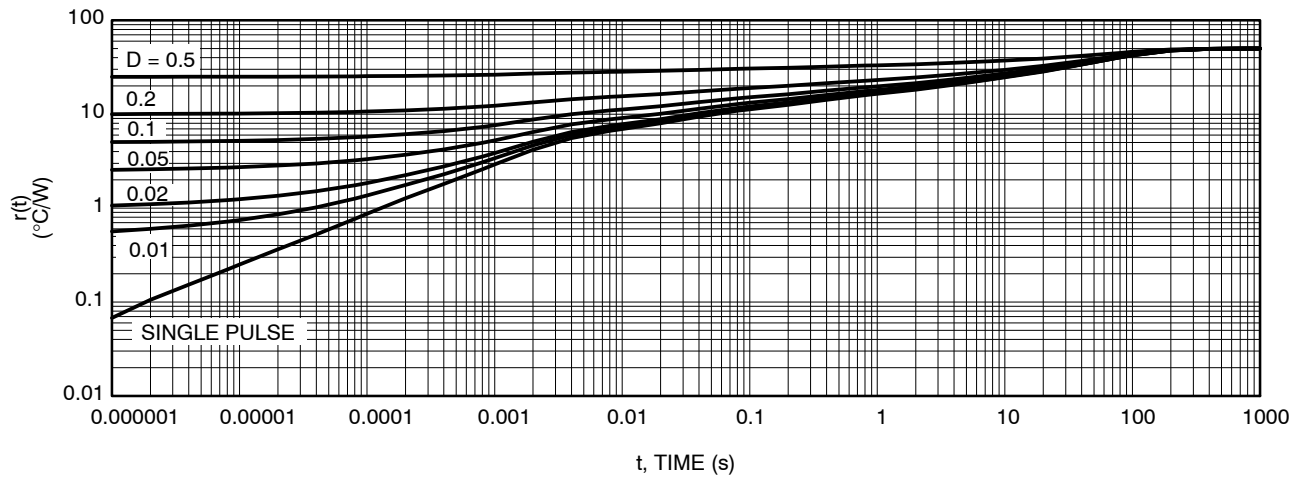


Figure 13. Thermal Response

PACKAGE DIMENSIONS

The drawing illustrates the mechanical specifications of a 5-pin D-subminiature connector. It includes the following views and dimensions:

- TOP VIEW:** Shows the connector's footprint with dimensions $2X$, 0.20 , C , D , A , B , $2X$, 0.20 , C , $E1$, E , and pin positions 1, 2, 3, 4. A feature with a triangular symbol and '2' is also indicated.
- SIDE VIEW:** Shows the profile of the connector with dimensions 0.10 , C , A , and 0.10 , C . A dashed circle indicates the location of **DETAIL A**.
- DETAIL A:** A magnified view of the contact area showing dimensions $4X$, θ , $A1$, C , $SEATING PLANE$, $3X$, e , and c .
- SOLDERING FOOTPRINT:** Shows the dimensions for the solder pads, including $8X$, b , 0.10 , C , A , B , 0.05 , c , L , $e/2$, 1 , 4 , K , $E2$, $PIN 5 EXPOSED PAD$, $L1$, M , G , $D2$, $3X$, 1.270 , 0.965 , 1.330 , $2X$, 0.495 , 3.200 , 1.530 , $2X$, 4.560 , and 0 .

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.90	1.00	1.10
A1	0.00	---	0.05
b	0.33	0.41	0.51
c	0.23	0.28	0.33
D	5.15 BSC		
D1	4.50	4.90	5.10
D2	3.50	---	4.22
E	6.15 BSC		
E1	5.50	5.80	6.10
E2	3.45	---	4.30
e	1.27 BSC		
G	0.51	0.61	0.71
K	1.20	1.35	1.50
L	0.51	0.61	0.71
L1	0.05	0.17	0.20
M	3.00	3.40	3.80
θ	0°	---	12°

PIN 1. SOURCE
2. SOURCE
3. SOURCE
4. GATE
5. DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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